Errata

X-Ray Powder Diffraction Data of a New Compound
Na$_2$Ca$_4$Mg$_2$Si$_4$O$_{15}$
By Robert Hausner
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The following entries, omitted in the original publication of
the above article, should be entered in Table 2.
1.91974 620,713 47.341
1.98762 2 47.919

In the data entry, Table 2, beginning 1.634 the bar above
the 114 entry was incorrectly positioned. It should 114.

Powder Diffraction Data for Nitroguanidine, C(NH$_2$)$_2$NNO$_2$
By E.K. Vasil’ev, A.N. Sapozhnivov, Z.A. Dobronravova and
L.I. Vereshchagin
The Institute of the Earth’s Crust, Academy of Sciences, Siberian Department,
Irkutsk 664033, U.S.S.R.

The entire concluding paragraph, part of which was missing
in the original publication of this article, and the reference
listings, also missing, are given below:

Compared to PDF 7-634, which was obtained by camera
methods, the data in Table 2 are of higher precision and
accuracy (from the use of an internal standard) in interpla-
nar spacings, cover a wider range and contain additional
weak and moderate intensity reflections.

References
9, 573-578.
234-239.
47, 1063.

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Dr. William M. Fink
We regret to announce the death of William M. Fink,
one of the founders of the International Centre for
Diffraction Data. Dr. Fink died April 2, 1992, at the
age of 95.

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International Report

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Regional Correspondents

Australia
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Results of Election of Officers and Directors
JCPDS–International Centre for Diffraction Data
March 1992
Chairman – Gerald G. Johnson, Jr.
Vice Chairman – Jan W. Visser
Treasurer – Gerhard R. Fischer
Chairman, Technical Committee – Ting C. Huang
Members-at-Large, Board of Directors
Thomas N. Blanton
Walter Eysel
James A. Kaduk
Melvin H. Meuller
Robert L. Snyder
Past Chairman – Ludo K. Frevel

Daniel Louër to Receive the J.D. Hanawalt Award
The JCPDS–International Centre for Diffraction Data takes pleasure in announcing that Professor Daniel Louër, Université de Rennes I, Rennes, France, has been selected to receive the J.D. Hanawalt Award for excellence in the field of powder diffraction. The presentation of the award will take place at the European Powder Diffraction Conference, EPDIC-2, Enschede, The Netherlands, July-August 1992.

Calendar of Meetings

1992

ICDD Clinic on X-Ray Powder Diffraction
June 1992 Fundamentals
June 1992 Advanced Techniques
Swarthmore College, Swarthmore, Pennsylvania, USA.
The ICDD X-Ray Clinics are the continuation of the SUNY Clinics which, for some twenty-five years, were held at the State University of New York at Albany. The ICDD assumed responsibility for these clinics in 1990. The Clinic is presented in two separate week-long sessions, each of which stands alone as a complete course.

Contact: Mario Fornoff, ICDD X-Ray Clinic, International Centre for Diffraction Data, 1601 Park Lane, Swarthmore, PA 19081, USA. Phone (215) 329-9400, FAX (215) 328-2503

Symposium Roentgendiffraktometrie in der Materialwissenschaft
June 25-26, 1992
Freiberg/Sachsen, Germany
Contact: Simone Neubert, Freiberger Prazisionsmechanik GmbH, Hainichener Strasse 2 a, D-9200 Freiberg, Germany.

ICDD Clinic on X-Ray Fluorescence Spectroscopy
July 1992 Fundamentals
July 1992 Advanced Techniques
Swarthmore College, Swarthmore, Pennsylvania, USA
Details and Contact: Same as ICDD Clinic on X-Ray Powder Diffraction (above).

Second European Powder Diffraction Conference (EPDIC-2)
July 30-August 1, 1992
University of Twente, The Netherlands
Contact: Chairman Scientific Program: Prof. Dr. E. Tillmans, Institute fur Mineralogie und Kristallographie der Universitat Wien, or Chairman Organizing Committee: Dr. T. W. Ryan, Philips Analytical, Lelyweg 1, 7602 EA Almelo, The Netherlands, phone +31 5490 39443.

This meeting, intended as a forum for all European powder diffractionists, is scheduled to be held at the University of Twente, between Hengelo and Enschede, in the beautiful eastern part of the Netherlands, preceding the 14th European Crystallographic Meeting (ECM-14), August 3-7, 1992, at the same location. All practical and theoretical aspects of powder diffraction are welcome. The subjects of Glass and amorphous substances, Electron diffraction, Thin films, Synchrotron radiation, Stress analysis, and Structure determination from powder data will be highlighted.

14th European Crystallographic Meeting (ECM-14)
August 2-7, 1992
Enschede, The Netherlands
Contact: ECM-14, Dr. H.J. Bruins Slot, Secretary, CAOS/CAMM Center, University of Nijmegen, Toernooiveld, 6525 ED Nijmegen, The Netherlands

1992 Annual Denver Conference on Applications of X-Ray Analysis
August 3-7, 1992
Colorado Springs, Colorado, USA
Contact: Lynne Bonno, Conference Secretary, Department of Engineering, University of Denver, Denver, CO 80208, USA. Phone (303) 871-3515.

Special sessions include the Plenary Session on Grazing Incidence X-ray Characterization of Materials, Low Atomic Number XRF (Be-F) and Chemical State Analysis, On-Line Application of X-ray Analysis, Applications of XRF to Industrial Processes, Imaging/Tomography, Applications of Total Diffraction Patterns, High Temperature Non-ambient X-ray Diffraction, Polymer Diffraction, and X-ray Stress Analysis. Tutorial Workshops (1/2 day unless otherwise noted) scheduled are Calibration and Maintenance of X-ray Spectrometers; XRF Sample Preparation (one day); Use of Pure Intensities for XRF Math Corrections; X-ray Microbeam Imaging and Analysis; Alignment and Calibration of Diffractometers;